

Notice of References Cited

Application/Control No. 09/776,981	Applicant(s)/Patent Under Reexamination LEE ET AL.		
Examiner	Art Unit		
Fric Chang	2116	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,553,525 B1	04-2003	Shephard, III, Philip George	714/733
	В	US-			
	С	US-			
	D	US-			
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	F	US-	•		
	G	US-			
	H	US-			
	-	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

TOTAL OF THE STATE						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 06103249 A	04-1994	Japan	NAKANISHI et al.	G06F 15/16
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	Р					
	Q					
	R					
	s					
	Т					,

NON-PATENT DOCUMENTS

	MONTH ATENT DOCUMENTO				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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